### **ARCHIVE 2009**

### **BiTS and Pieces—Past, Present and Future**

by

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### **ABSTRACT**

'he BiTS Workshop is the world's premier event dedicated to providing a forum for the latest Information about test and burn-in socketing and related fields. It has become the annual event for those involved in the "backend" of semiconductor processing and draws attendees and exhibitors from around the world for learning and networking. The workshop has been held in the Phoenix area since its inception in 2000.

This year represents a significant milestone as the workshop celebrates its 10th meeting. During the history of BiTS we have experienced good food, good company and excellent and perceptive presentations. While all the presentations are available on the BiTS website, perhaps the 10th anniversary is a good time to take a little time to reflect on some of the previous presentations.

The BiTS Workshop's archives are a tremendous source of information. This presentation will reexamine some of the presentations from the previous 9 workshops. Specific papers will be highlighted and some "sense" and "perspective" given - the past presentations will be dusted-off and a light shone into this library of information.

After looking backward, a look forward will examine packaging trends and the potential issues the audience will have to face in the coming years.

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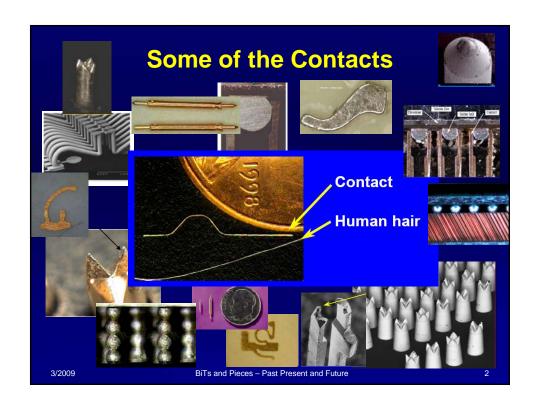
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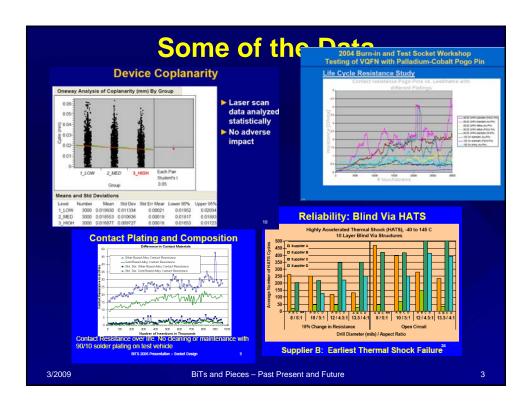
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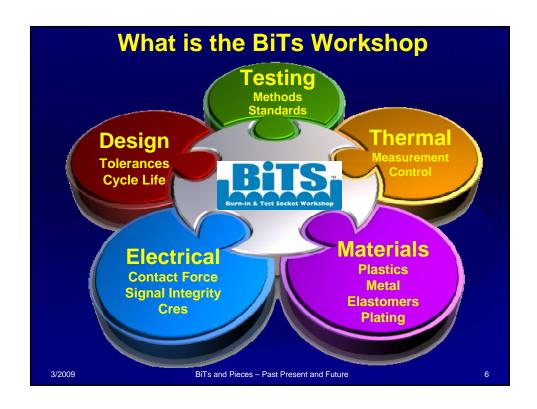






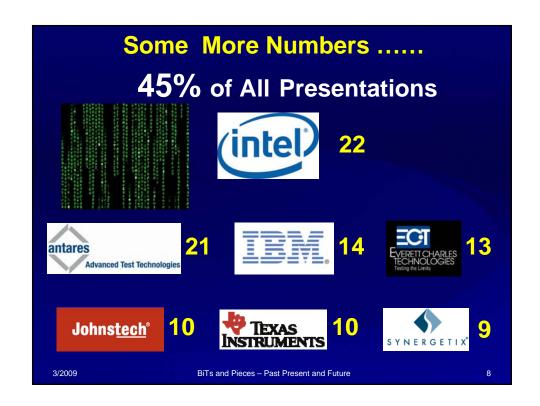




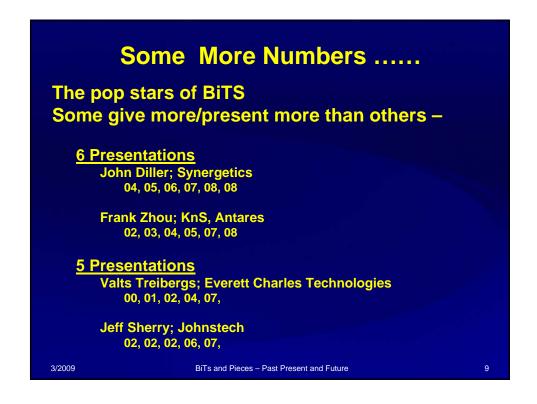




























### **But First There Was ......**

### 1996 An idea – John Hartstein

Bring in key customers and give them insight into our engineering capabilities our facilities and share knowledge about socket design, materials.

### 1997 May "Wells Burn-in Socket Symposium" South Bend, Indiana

Kick Off Dinner Johnny Lattner - Heisman Trophy Winner - University of Notre Dame Valts Treibergs Socket Overview

The Contact Spring Member - Physics Kevin Young Lee Palmer Contact Materials and Material Properties

Max Peel Faillure Modes, Functional Interrelationships, and Test Sequences
Dr. Mort Antler
Chung Namgung PCB Manufacturability, Laminate Material, Final Metal Finish and Micro Vias
Jim Ostendorf History of Burn-in Boards, Electrical and Mechanical Limitations, and Market Directions

### **Attendees included**

Micron, IBM, AMD, TI, Motorola, Dynavision, Siemens (then Infineon, now Qimonda)

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# And of course ...... 3/2009 BiTs and Pieces - Past Present and Future 16







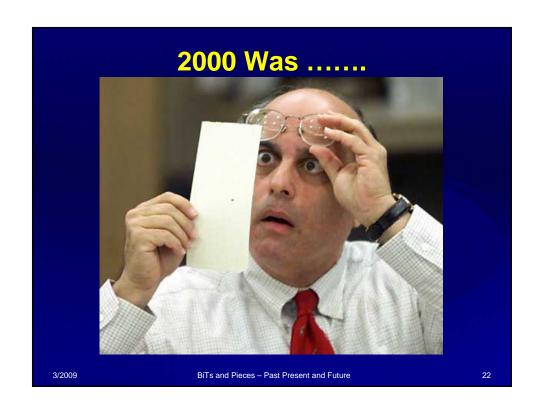




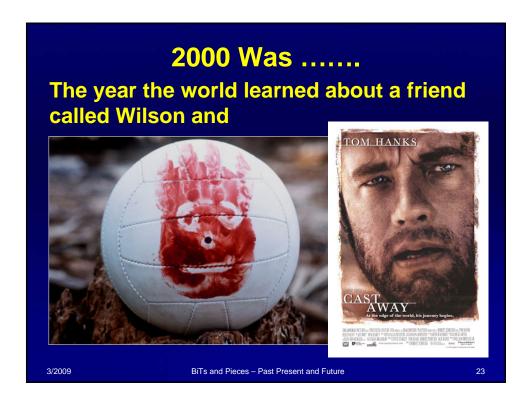






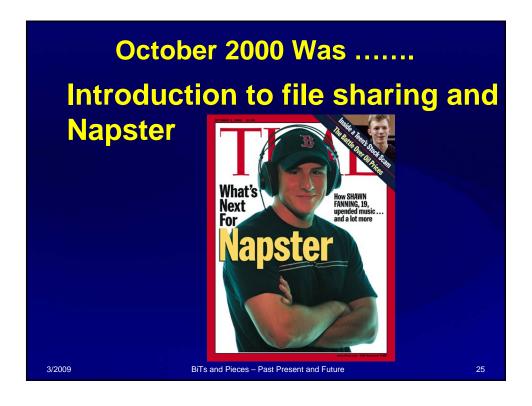






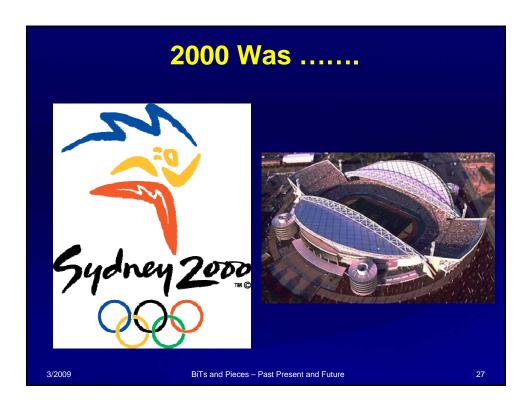






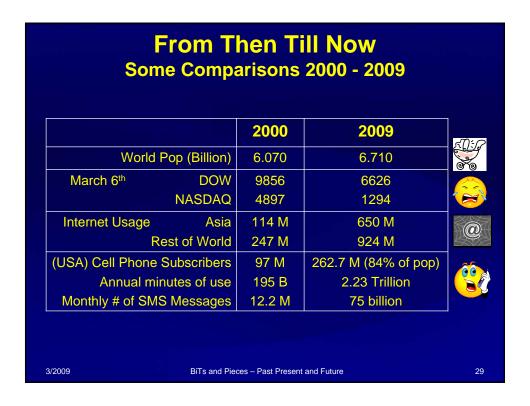


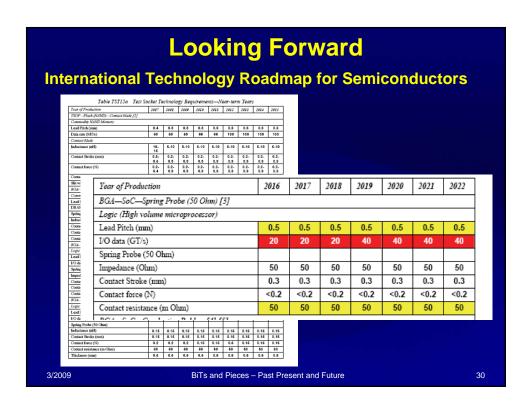






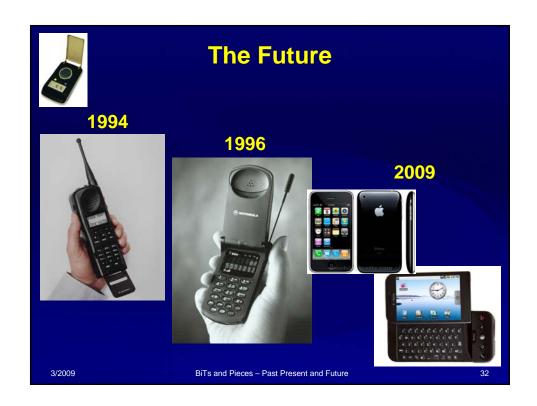




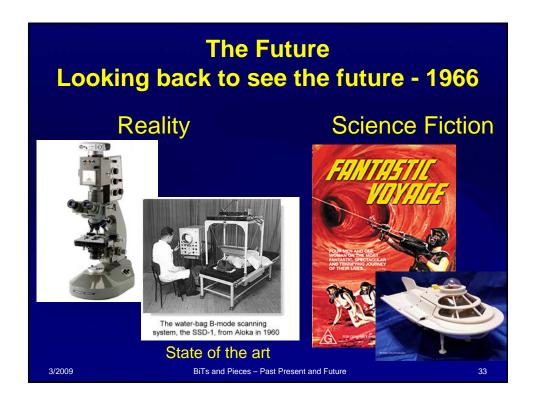


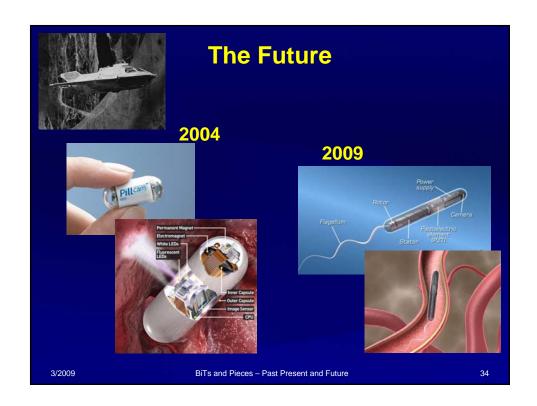














The Future...... 2015 2020

?
We can dream and imagine

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